

TMS320TCI100Q Digital Signal Processor Silicon Revision 2.0, 1.0

Silicon Errata



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TMS320TCI100Q Digital Signal Processor

Silicon Revision 2.0, 1.0

1 Introduction

This document describes the known exceptions to the functional specifications for the TMS320TCI100Q digital signal processor. [See the *TMS320TCI100Q Fixed-Point Digital Signal Processor* data sheet (literature number [SPRS251](#)).] Throughout this document, TMS320C64x, C64x, and TCI100Q refer to TMS320TCI100Q.

For additional information, see the latest version of the *TMS320C6000 DSP Peripherals Overview Reference Guide* (literature number [SPRU190](#)).

This document also contains usage notes. Usage notes highlight and describe particular situations where the device's behavior may not match presumed or documented behavior. This may include behaviors that affect device performance or functional correctness. These notes will be incorporated into future documentation updates for the device (such as the device-specific data sheet), and the behaviors they describe will not be altered in future silicon revisions.

1.1 Device and Development Support Tool Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all DSP devices and support tools. Each DSP commercial family member has one of three prefixes: TMX, TMP, or TMS (e.g., **TMS320TCI100QGLZ**). Texas Instruments recommends two of three possible prefix designators for its support tools: TMDX and TMDS. These prefixes represent evolutionary stages of product development from engineering prototypes (TMX/TMDX) through fully qualified production devices/tools (TMS/TMDS).

Device development evolutionary flow:

TMX	Experimental device that is not necessarily representative of the final device's electrical specifications
TMP	Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification
TMS	Fully-qualified production device

Support tool development evolutionary flow:

TMDX	Development-support product that has not yet completed Texas Instruments internal qualification testing
TMDS	Fully-qualified development-support product

TMX and TMP devices and TMDX development-support tools are shipped against the following disclaimer:

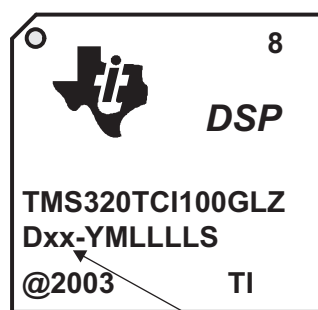
"Developmental product is intended for internal evaluation purposes."

TMS devices and TMDS development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (TMX or TMP) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

1.2 Revision Identification

The device revision can be determined by the die PG code marked on the top of the package. The location of the die PG code for the GLZ package is shown in [Figure 1](#).



Die PG Code

- A Qualified devices are marked with the letters "TMS" at the beginning of the device name, while nonqualified devices are marked with the letters "TMX" or "TMP" at the beginning of the device name.

Figure 1. Example, Die PG Codes for TMS320TCI100Q (GLZ)

Silicon revision is identified by a code on the chip. The code is of the format Dxx-YMLLLLLS. If xx is 20, then the silicon is revision 2.0, etc; If xx is 10, then the silicon is revision 1.0, etc.

Table 1. Die PG Codes

DIE PG CODES	SILICON REVISION	COMMENTS
20	2.0	TMX320TCI100Q, TMS320TCI100Q
10	1.0	TMX320TCI100Q, TMS320TCI100Q

2 Silicon Revision 2.0 Usage Notes and Known Design Exceptions to Functional Specifications

2.1 Usage Notes for Silicon Revision 2.0

Usage notes highlight and describe particular situations where the device's behavior may not match presumed or documented behavior. This may include behaviors that affect device performance or functional correctness. These notes will be incorporated into future documentation updates for the device (such as the device-specific data sheet), and the behaviors they describe will not be altered in future silicon revisions.

2.1.1 HPI: HWOB Bit in HPIC Register is Writable by CPU

On silicon revision 2.0 and earlier, the HWOB bit in the HPIC register is writable by the CPU, even though it should be writable by the Host only. Writing the incorrect value to the HPIC register will corrupt any data passed through the HPI.

When performing HPIC writes via the CPU, be sure to write the correct value into the HWOB bit.

2.1.2 TCP/VCP: TCP/VCP Memory Address Range Must be Accessed Using Only Doublewords (All C64x Devices)

On silicon revision 2.0 and earlier, the TCP/VCP memory address range (0x5000 0000 to 0x5FFF FFFF) must always be accessed by doubleword requests. Even if the C64x device does not support the TCP/VCP peripherals or if the TCP/VCP coprocessors are not enabled, this memory address range must always be accessed via doublewords. A request of any other size will cause the chip to hang. Users should be especially careful when using Code Composer Studio™ Integrated Development Environment (IDE), because Code Composer Studio requests memory data using word-sized accesses. Do not attempt to view this memory map region (0x5000 0000 to 0x5FFF FFFF) in a Code Composer Studio window. (Note: this region can be disabled in the Code Composer Studio memory map to prevent accidental access.)

For all TMS320C64x™ DSP devices, always access the memory address range 0x5000 0000 to 0x5FFF FFFF via doublewords.

2.1.3 EMIFA: Dead CLKOUT4/6

On silicon revision 2.0 and earlier, there is a usage condition concerning EMIFA which can affect the functionality of CLKOUT4 and CLKOUT6.

The EMIFA Global Control register (GBLCTL) controls the logic that outputs the internal CPU/4 or CPU/6 clocks to the CLKOUT4 and CLKOUT6 pins. The GBLCTL is registered with the AECLKIN clock; therefore, without a valid EMIF clock, it is possible to have unknown values in the GBLCTL register. Furthermore, without a valid EMIF clock, the EMIFA GBLCTL will not be reset to its default value.

To avoid a dead CLKOUT4 and/or CLKOUT6, a valid clock must be provided to EMIFA at all times. This can be implemented externally using AECLKIN or by setting the BEA[17:16] pins (EMIFA_CLK_SEL bits) to select the internal CPU/4 or CPU/6.

2.1.4 L1P Cache: Incorrect Update of the L1P Tag RAMs (All C64x Devices)

On TC1100Q silicon revision 2.0 and earlier, when the CPU is executing non-cacheable code from external memory and there is snoop activity from L2 to L1P occurring at the same time, an incorrect update to the L1P Tag RAM can occur.

Snoop activity from L2 to L1P can be generated two ways:

1. EDMA/QDMA activity to L2
2. Block cache invalidates initiated in L2

When there is a non-cacheable L1P fetch that is returned from L2 to L1P, **and** there is a snoop from L2 in the very next cycle, then the snoop tag read interferes with the tag/status RAM write for the non-cacheable data. This interference causes the tag RAMs to be incorrectly updated with the tag for that line, rather than discarding the write to the tags. When the NEXT access to that non-cacheable line in L2 occurs, the L1P incorrectly registers this as a hit and transfers data from the L1P rather than the desired external data.

To *avoid* an incorrect update of the L1P tag RAMs, do the following as best practice:

1. While executing code from non-cacheable space, **do not** perform either EDMA/QDMA transfers to L2 **or** block cache invalidates initiated in L2
2. Mark program code as cacheable as soon as possible.

2.2 Silicon Revision 2.0 Known Design Exceptions to Functional Specifications

Table 2. Silicon Revision 2.0 Advisory List

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Advisory 2.0.1**PCI: Slave Reads With a Long Latency Can Return Bad Data**

Revision(s) Affected

2.0 and earlier

Details

When an external master attempts to read memory from the DSP, it is issued a "Retry". The PCI will then go prefetch a FIFO's worth (32 words) of data. If this data takes an exceptionally long time to fetch (approximately 32K PCI cycles, ≈1 ms @ 33-MHz PCI), the PCI port can mishandle the return data and "delete" the first word of a PCI frame. The data returned to the master is address-shifted by one 32-bit word. For example, if {0,1,2,3,4, ...} is expected and {1,2,3,4,5 ...} is returned.

Data will only take that long to fetch if the access is to a very slow external memory, or there are large, slow DMAs using the same priority queue as PCI (which, by default, is medium). For performance reasons, the separation of DMA traffic is recommended.

For more detailed information on the EDMA peripheral, EDMA performance, and EDMA performance data, see the following reference guide and application notes:

- *TMS320C6000 DSP Enhanced Direct Memory Access (EDMA) Controller Reference Guide* (literature number [SPRU234](#))
- *TMS320C64x EDMA Architecture* application report (literature number [SPRA994](#))
- *TMS320C6000 EDMA IO Scheduling and Performance* application report (literature number [SPRAA00](#))
- *TMS320C64x EDMA Performance Data* application report (literature number [SPRAA02](#))

PCI slave reads that start in less than 32K PCI cycles will not return bad data.

Workaround

Do not use PCI to directly read from exceptionally slow external memories.

Do not put any other DMA activity on the same priority level as PCI.

If system considerations force a user to put other DMA activity on PCI's level, put only DMA traffic that will complete within the 32K PCI clock cycle limit.

Advisory 2.0.2	<i>PCI Reads May Get Ahead of PCI Writes When PCI Exceeds the Transfer Request Limit</i>
Revision(s) Affected	2.0 and earlier
Details	<p>When the PCI port exceeds its allocation of EDMA Transfer Requests (TRs), it can re-order read and write memory transactions. This can cause PCI slave reads to return "stale" data</p> <p>When the PCI port reaches its limit for the number of outstanding TRs, it must wait for previously issued TRs to complete. While the PCI port is waiting, any pending write data and/or read requests will be held pending in internal buffers. When a TR allocation is available, any pending read requests are serviced before any pending write data, regardless of the order in which the write data and read request were received. This can potentially allow the read request to get ahead of the write data, and return "stale" results.</p>
Workaround	<p>TI recommends that good EDMA resource allocation be used to prevent the problem. For detailed information on EDMA resource allocation, refer to the <i>TMS320C64x EDMA Architecture</i> application report (literature number SPRA994).</p> <p>The following guidelines can help prevent PCI from running out of available TRs:</p> <ul style="list-style-type: none">• Do not place large or slow transfers on EDMA priority levels at or above the PCI's priority level.• Increase PCI's TR allocation limit. For detailed information, refer to the <i>TMS320C6000 DSP Peripheral Component Interconnect (PCI) Reference Guide</i> (literature number SPRU581). <p>The following guidelines can ensure correct read data:</p> <ul style="list-style-type: none">• Do not read any of the previous 32 words written.• Write 32 words of "dummy" data after writing "real" data.

3 Silicon Revision 1.0 Usage Notes and Known Design Exceptions to Functional Specifications

3.1 Usage Notes for Silicon Revision 1.0

Usage notes highlight and describe particular situations where the device's behavior may not match presumed or documented behavior. This may include behaviors that affect device performance or functional correctness. These notes will be incorporated into future documentation updates for the device (such as the device-specific data sheet), and the behaviors they describe will not be altered in future silicon revisions.

3.1.1 Electronic Discharge (ESD) Performance

The TM320TC1100Q devices were subjected to Human Body Model (HBM) ESD testing per EIA/JESD22-A114. Tests were passed at ± 2 KV with the exception of a single pin combination. When the RSV pin (G2) is stressed negative to the PLLV pin (J6) the passing voltage is 750 V. These two pins are not adjacent on the package and no more than normal ESD handling precautions are required.

The device has also been subjected to Charged Device Model (CDM) ESD testing per EIA/JESD22-C101, passing at the ± 500 V level.

3.2 Silicon Revision 1.0 Known Design Exceptions to Functional Specifications

Table 3. Silicon Revision 1.0 Advisory List

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Advisory 1.0.1 ***EMIF: PDT Write Transfers Fail When PDTWL Equals 3***
Revision(s) Affected 1.0

Details During a PDT write transfer, the PDT, PDTA, PDTDIR, SDWE, and SDCAS signals will not be driven to their appropriate states when a non-PDT write is followed by a PDT write to a different bank. The incorrect behavior of PDT, PDTA, PDTDIR, SDWE, and SDCAS can result in data corruption, as well as bus contention. This only occurs when PDTWL is set equal to 3 in the PDTCTL register.

Workaround When performing both non-PDT writes and PDT writes to the same CE space, do not set PDTWL equal to 3.

Advisory 1.0.3 ***EMIF: Asynchronous RAM AC Timings Different From Data Sheet Specifications***
Revision(s) Affected 1.0

Details [Table 4](#) reflects the differences between the actual TCI100Q silicon revision 1.0 values and the values specified in the *TMS320TC100Q Fixed-Point Digital Signal Processor* data sheet (literature number [SPRS251](#) or higher) for the EMIF peripheral - Asynchronous RAM.

Table 4. Timing Requirements for Asynchronous Memory Cycles for EMIFA and EMIFB Modules

NO.		DATA SHEET VALUES		REVISION 1.0 ACTUAL VALUES		UNIT
		MIN	MAX	MIN	MAX	
7	$t_{h(EKO1H-ARDY)}$ Hold time, ARDY valid after ECLKOUTx high	1		1.5		ns

Advisory 1.0.4
PCI: AC Timings Different From Data Sheet Specifications
Revision(s) Affected

1.0

Details

[Table 5](#) reflects the differences between the actual TCI100Q silicon revision 1.0 values and the values specified in the *TMS320TCI100Q Fixed-Point Digital Signal Processor* data sheet (literature number [SPRS251](#) or higher) for the PCI peripheral.

Table 5. Timing Requirements for PCI Inputs

NO.		DATA SHEET VALUES		REVISION 1.0 ACTUAL VALUES		UNIT
		MIN	MAX	MIN	MAX	
6	$t_{h(IV-PCLKH)}$ Hold time, input valid after PCLK high	0		0.9		ns

Advisory 1.0.5
HPI: AC Timings Different From Data Sheet Specifications
Revision(s) Affected

1.0

Details

[Table 6](#) reflects the differences between the actual TCI100Q silicon revision 1.0 values and the values specified in the *TMS320TCI100Q Fixed-Point Digital Signal Processor* data sheet (literature number [SPRS251](#) or higher) for the HPI peripheral.

Table 6. Switching Characteristics Over Recommended Operating Conditions During Host-Port Interface Cycles

NO.		DATA SHEET VALUES		REVISION 1.0 ACTUAL VALUES		UNIT
		MIN	MAX	MIN	MAX	
8	$t_{d(HDV-HRDYL)}$ Delay time, HD valid to \overline{HRDY} low	-3		-3.5		ns

Advisory 1.0.6 ***L2 Cache: Accesses to Mapped L2 RAM Update L2 LRU Information***

Revision(s) Affected 1.0

Details CPU accesses to L2 RAM addresses incorrectly cause updates to the "Least-Recently Used" (LRU) state information in the L2 cache. This may cause an increased number of L2 cache misses in some systems.

The L2 cache implements a 4-way set-associative cache. The cache uses the (LRU) information to determine what "way" within each set is least recently used. When the CPU accesses data in L2 cache, the L2 controller determines what "way" holds the data in that set, and marks that "way" as most-recent. When allocating a new line in the cache, the L2 controller evicts the line in the set from the least-recently used "way" under the assumption that more-recently accessed data is more relevant.

When the CPU accesses data in L2 SRAM, either via program fetches or data accesses, the L2 cache is incorrectly updated by the L2 controller. The L2 controller updates the LRU as if the access was to "way 0" in the cache. This causes the LRU history to not reflect the actual sequence of accesses to L2 cache. As a result, the L2 may not choose the actual least-recently used line during an eviction.

Only CPU accesses to L2 RAM cause this update to LRU information in L2 cache. DMA accesses to L2 RAM do not trigger updates to the L2 LRU information.

Workaround

Perform one of the following three workarounds:

- Choose an L2 cache size that fits your cached working set. The advisory primarily impacts programs that are significantly larger than the L2 cache size.
- Explicitly remove cached contents from L2 when finished with them. The L2 cache allocates "invalid" lines within each set before consulting the LRU. Programs may do this using "block invalidate" or "block writeback-invalidate" commands in the L2 cache.
- Lay out buffers in L2 RAM so they *do not* conflict with buffers or code held in L2 cache. L2 RAM addresses map onto L2 sets in the same manner as external memory addresses.

For more detailed information on the organization and manipulation of the L2 cache, see the *TMS320C64x DSP Two-Level Internal Memory Reference Guide* (literature number [SPRU610](#)).

Advisory 1.0.7 **L2 Cache: L2 Controller Incorrectly Updates LRU for Accesses in L2 Cache**

Revision(s) Affected 1.0**Details**

The L2 cache implements a 4-way set-associative cache. The cache uses the "Least-Recently Used" (LRU) information to determine what "way" within each set is least recently used. When the CPU accesses data in L2 cache, the L2 controller determines what "way" holds the data in that set, and marks that "way" as most-recent. When allocating a new line in the cache, the L2 controller evicts the line in the set from the least-recently used "way" under the assumption that more-recently accessed data is more relevant.

For this advisory, CPU accesses which hit L2 cache do not correctly update the LRU information for the set accessed. Instead of storing the LRU information back to the set being accessed, the L2 controller stores the information to 3 adjacent sets.

LRU information is stored in groups of 4 sets. The 3 adjacent sets affected by the current set are defined as follows:

- Group 1 contains sets 0, 1, 2, 3
- Group 2 contains sets 4, 5, 6, 7
- etc.

For example, during an access to set 5, the L2 controller incorrectly stores the LRU information to sets 4, 6, 7.

As a result of this issue, repeated misses to the same set with no intervening accesses to adjacent sets will allocate from the same "way". This can make the L2 cache appear to "thrash". A series of misses to consecutive sets in L2 cache may appear to allocate with reduced associativity; that is, L2 could appear to behave as a 2-way or direct-mapped cache.

Workaround

Perform one of the following three workarounds:

- Choose an L2 cache size that fits your cached working set. The advisory primarily impacts programs that are significantly larger than the L2 cache size.
- Explicitly remove cached contents from L2 when finished with them. The L2 cache allocates "invalid" lines within each set before consulting the LRU. Programs may do this using "block invalidate" or "block writeback-invalidate" commands in the L2 cache.
- Offset external buffers that are accessed as part of the same working set so that accesses to the buffers are at least 4 L2 sets apart (512 bytes). This will prevent the buffers from "thrashing" each other in L2 cache.

For more detailed information on the organization and manipulation of the L2 cache, see the [TMS320C64x DSP Two-Level Internal Memory Reference Guide](#) (literature number [SPRU610](#)).

Advisory 1.0.8 ***JTAG: Boundary Scan IDCODE_REGISTER Incorrect***

Revision(s) Affected 1.0

Details When reading the Boundary Scan IDCODE_REGISTER, an incorrect value is returned. The upper 16 bits of the Boundary Scan IDCODE_REGISTER, which contain the variant field (***silicon revision*** information) and a portion of the ***device id*** field, are incorrect. This problem is due to data corruption in the reset configuration logic.

Workaround Disregard the upper 16 bits of data contained in the Boundary Scan IDCODE_REGISTER. The lower 16 bits of the Boundary Scan IDCODE_REGISTER, which include the lower 4 bits of the ***device id*** field, can still be read.

This advisory issue will be fixed in the next ***major*** silicon revision.

Advisory 1.0.9 ***EMIF: PDT Transfers Fail When Accessing the Same SDRAM Page as Non-PDT Transfers***

Revision(s) Affected 1.0

Details When PDT and non-PDT transfers occur to the same SDRAM page, PDTA, PDT, and PDTDIR may not be driven to their appropriate state. The incorrect behavior of these signals can result in PDT data corruption.

Workaround Place all PDT transfers, whether reads or writes, in a memory range that is an aliased version of the physical SDRAM. For example, if SDRAM is in CE0 and is 128 Mbytes (MB) in depth, then the functional addressable space is 0x8000 0000 through 0x87FF FFFF and all normal CPU and non-PDT DMA transfers should access this memory range. The "aliased" view of the SDRAM is at address 0x8800 0000 through 0x8FFF FFFF and must be used for all PDT transfers. Similarly, if SDRAM is 64 MB in depth, the functional addressable view is 0x8000 0000 through 0x83FF FFFF and the "aliased" view is 0x8400 0000 through 0x87FF FFFF. The aliased view accesses the same underlying physical address as the functional view.

The address space for the "aliased" view can be created by bit-wise ORing the "logical address" (functional address) in use as follows:

- For 128 MB, OR with 0x0800 0000
- For 64 MB, OR with 0x0400 0000
- For 32 MB, OR with 0x0200 0000
- For 16 MB, OR with 0x0100 0000

This workaround is ONLY applicable if the CE space has less than or equal to 128 MB of SDRAM connected to it. If a CE space is full (maximum addressable space is 256 MB), then that CE space cannot support PDT transfers.

Advisory 1.0.11 *PCI/HPI: Data Corruption Can Occur When DV_{DD} Powers Up Before CV_{DD}*

Revision(s) Affected 1.0

Details **Advisory 1.0.11 - PCI/HPI: Data Corruption Can Occur When DV_{DD} Powers Up Before CV_{DD} (for all device speeds) supersedes Advisory 1.0.2 - PCI/HPI: Data Corruption Can Occur When CV_{DD} = 1.1 V.**

When DV_{DD} powers up before CV_{DD}, the PCI/HPI I/O buffers can be initialized incorrectly - causing them to be stuck in a Hi-Z condition. This can result in incorrect data on the bus, deadlocked interface or other undesirable operation.

Workaround

One of the following options is available as a Workaround:

- Power up the CV_{DD} supply before the DV_{DD} supply (see [Table 7](#) and [Figure 2](#)) or
- Do not use the PCI and/or HPI peripherals. Do not use GP[15:9] as outputs.

Table 7. Timing Requirements for Power-On Sequence⁽¹⁾

NO.		-850		UNIT
		MIN	MAX	
1	t _{d(CVDD-DVDDR)} Delay time, CV _{DD} supply ready to DV _{DD} supply ramp start	0.5	200	ms

⁽¹⁾ Delay time from CV_{DD} is referenced to the supply reaching its minimum operating voltage.

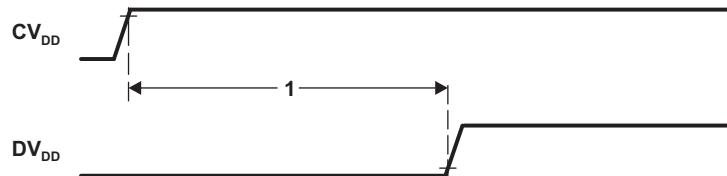


Figure 2. Power-On Sequence Timing

Appendix A Revision History

This silicon errata revision history highlights the technical changes made to the SPRZ229E revision to make it an SPRZ229F revision.

Scope: Applicable updates relating to the TMS320TC1100Q device have been incorporated.

Table A-1. TMS320TC1100Q Revision History

SEE	ADDITIONS/MODIFICATIONS/DELETIONS
Section 1.2	Revision Identification: Updated Figure 1 , Example, Die PG Codes for TMS320TC1100Q (GLZ)

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